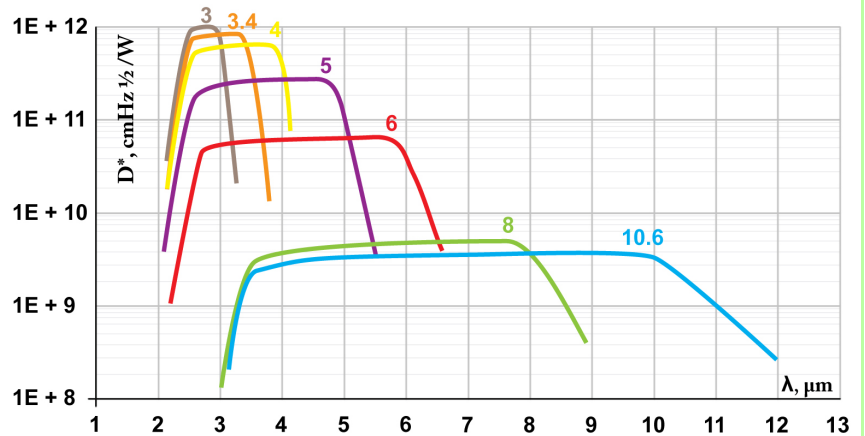
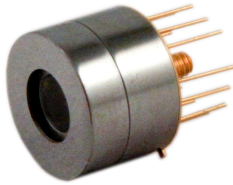


# PVI-4TE SERIES

# 2-12 μm IR PHOTOVOLTAIC DETECTORS THERMOELECTRICALLY COOLED OPTICALLY IMMERSED



## FEATURES

- High performance in the 2-13 μm wavelength range
- Fast response
- No flicker noise
- Convenient to use
- Wide dynamic range
- Compact, rugged and reliable
- Low cost
- Prompt delivery
- Custom design upon request

## DESCRIPTION

PVI-4TE- $\lambda_{opt}$  photodetectors series ( $\lambda_{opt}$  - optimal wavelength in micrometers) feature four-stage thermoelectrical cooler IR photovoltaic detector, optically immersed to high refractive index GaAs hyperhemispherical (standard) or hemispherical or any intermediate lens (as option) for different acceptance angle and saturation level. The devices are optimized for the maximum performance at  $\lambda_{opt}$ . Cut-on wavelength can be optimized upon request. Reverse bias may significantly increase speed of response and dynamic range. It results also in improved performance at high frequencies, but 1/f noise that appears in biased devices may reduce performance at low frequencies.

Highest performance and stability are achieved by application of variable gap (HgCd)Te semiconductor, optimized doping and sophisticated surface processing. Custom devices with quadrant cells, multielement arrays, different windows, lenses and optical filters are available upon request.

Standard detectors are available in TO-8 packages with BaF2 windows. Other packages, windows and connectors are also available.

## SPECIFICATION

@20°C

CHARACTERISTICS	UNITS	PVI-4TE-3	PVI-4TE-3.4	PVI-4TE-4	PVI-4TE-5	PVI-4TE-6	PVI-4TE-8	PVI-4TE-10.6
$\lambda_{opt}$	μm	3	3.4	4	5	6	8	10.6
Detectivity <sup>1)</sup> :								
@ $\lambda_{peak}$	cmHz <sup>1/2</sup> /W	$\geq 1 \times 10^{12}$	$\geq 8 \times 10^{11}$	$\geq 6 \times 10^{11}$	$\geq 3 \times 10^{11}$	$\geq 6 \times 10^{10}$	$\geq 5 \times 10^9$	$\geq 4 \times 10^9$
@ $\lambda_{opt}$		$\geq 8 \times 10^{11}$	$\geq 7 \times 10^{11}$	$\geq 4 \times 10^{11}$	$\geq 1 \times 10^{11}$	$\geq 4 \times 10^{10}$	$\geq 4 \times 10^9$	$\geq 2 \times 10^9$
Responsivity @ $\lambda_{opt}$	A/W	$\geq 0.5$	$\geq 0.8$	$\geq 1$	$\geq 1.3$	$\geq 1.5$	$\geq 1.5$	$\geq 0.7$
Time constant	ns	$\leq 20$	$\leq 20$	$\leq 20$	$\leq 20$	$\leq 15$	$\leq 8$	$\leq 6$
Resistance-optical area product	$\Omega \times \text{cm}^2$	$\geq 30000$	$\geq 2000$	$\geq 800$	$\geq 40$	$\geq 3$	$\geq 0.06$	$\geq 0.05$
Operating temperature	K	~195						
Acceptance angle, F/#	deg, -	36, 1.62						

<sup>1)</sup> Data sheet states minimum guaranteed D\* values for each detector model. Higher performance detectors can be provided upon request.

<sup>2)</sup> Faster response may be achieved with high-frequency-optimized devices.

Type	Length or diameter [mm]									
	0.025	0.05	0.1	0.2	0.25	0.5	1	2	3	4
PVI-4TE-3					O	X	X	O		
PVI-4TE-3.4					O	X	X	O		
PVI-4TE-4					O	X	X	O		
PVI-4TE-5					O	X	X	O		
PVI-4TE-6					O	X	X	O		
PVI-4TE-8				X	X	X <sup>1)</sup>	P			
PVI-4TE-10.6				X	X	X <sup>1)</sup>	P			

<sup>1)</sup> Custom detector may require reverse bias in order to increase dynamic resistance and improve frequency response.

X – standard detectors

P – default with reverse bias

O – detectors available on request, parameters may differ from these in data sheets

